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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/073,464	TIEDJE ET AL	
Examiner	Art Unit	
Sarae Bausch	1634	

SEARCHED					
Class	Subclass	Date	Examiner		
			:		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Updated Inventor search (east, Palm)	3/13/2006	SLB		
Updated search notes (East, STN, google)	3/13/2006	SLB		
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